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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): DOI et al.	Atty. Dkt.: 01-465
Serial No.: 10/653,075	Group Art Unit: 2154
Filed: September 3, 2003	Examiner: Unknown
Title: <b>CONTROL SYSTEM HAVING ABNORMALITY MONITOR FUNCTION</b>	
Commissioner for Patents Alexandria, VA 22313-1450	Date: January 9, 2007



SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. §1.56, the reference(s) listed on the attached Form PTO-1449 is/are being brought to the attention of the Examiner without any admission that it/they constitute(s) statutory prior art, or without any admission that it/they contain(s) subject matter that anticipates the invention or renders the invention obvious to a person of ordinary skill in the art.

Further, pursuant to 37 C.F.R. §1.97(e), the undersigned hereby certifies that each listed reference was first cited in a Communication (copy and English translation enclosed) from a foreign patent office in connection with a counterpart foreign application not more than three months prior to the filing of this statement.

Although no fees are believed to be due at this time, it is respectfully requested that any such fees be charged to Deposit Account 50-1147. Also, the Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed reference(s) has/have been considered and made of record.

Respectfully submitted,

A handwritten signature in black ink, appearing to read "David G. Posz".

David G. Posz  
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FORM PTO-1449	ATTY. DKT NO.	01-465	SER. NO.	10/653,075
	APPLICANT	DOI et al.		
	FILING DATE	September 3, 2003	GROUP	2154



## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

## FOREIGN PATENT DOCUMENTS

## TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract
		JP-A-04-260902	9/16/92	JAPAN						X
		JP-A-10-326109	12/8/98	JAPAN						X

\* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

	Notice of Reason for Rejection from Japanese Patent Office issued on December 12, 2006 for the corresponding Japanese patent application No. 2002-267050 (a copy and English translation thereof)	
EXAMINER	DATE CONSIDERED	